

<b>Notice of References Cited</b>	Application/Control No. 10/501,864	Applicant(s)/Patent Under Reexamination TAMURA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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*	N	JP 2000-309701	11-2000	JPC	Yamazaki, Yuei	----
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**NON-PATENT DOCUMENTS**

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